E1 213 Pattern Recognition and Neural Networks

P.S. Sastry sastry@iisc.ac.in

Reference Material

- ► R.O.Duda, P.E.Hart and D.G.Stork, 'Pattern Classification', Johy Wiley, 2002
- ► C.M.Bishop, 'Pattern Recognition and Machine Learning', Springer, 2006.
- ➤ T.Hastie, R.Tibshirani and J.Friedman 'The Elements of Statistical Learning: Data Mining, Inference and Prediction', Springer, 2009.
- ► S Shalev-Shwartz and S. Ben-David, 'Understanding Machine Learning: From Theory to Algorithms', Cambridge University Press, 2014.
- ► I.Goodfellow, Y.Bengio and A. Courville, 'Deep Learning', MIT Press, 2016
- A.Zhang, Z.C.Lipton, M.Li, A.J.Smola, 'Dive into Deep Learning', 2019 (free PDF available)
- ► Link to my online video course on Pattern Recognition: https://nptel.ac.in/courses/117/108/117108048/

Course Prerequisites / Background needed

- Probability Theory
 - joint distributions/densities of multiple random variables, conditional distributions, expectation, conditional expectation, laws of large numbers, (convergence of seq of random variables, Markov chains)
- Matrix theory/Linear Algebra
 - vector spaces, bases, dimension, linear transformations, matrices, rank, nulity, eigen values and eigen vectors
- Optimization techniques
 - unconstrained optimization, necessary and sufficient conditions, descent methods, gradient descent, second order methods, constrained optimization, Kuhn-Tucker conditions

Course grading

- ► Mid-Term Tests and Assignments: 50% Final Exam: 50%
- ► Two mid-term tests and 4-5 assignments (involves programming)

Before we begin

Please ask yourself whether this is the right course for you

- This is a first-level course on ML
- This course follows a statistical (or probability-based) approach to ML.
- Course is more 'theoretical' (algorithms and analysis)
- This course does NOT teach any Python programming or use of any standard packages.
- ▶ This is not a course on deep learning. Many topics other than neural network models would be covered.

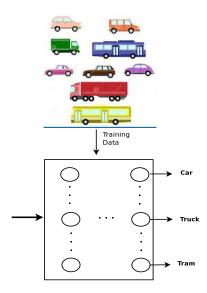
Machine Learning

- Methods for automatically detecting 'regularities' in data in a form that is suitable for prediction or other decision-making scenarios.
- ▶ We can think of machine learning as a principled approach to fitting models for many different kinds of data.

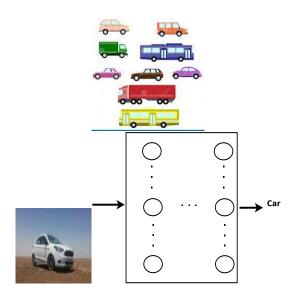
Machine learning encompasses many different data analysis scenarios.

- Predictive or Supervised Learning:
 - ▶ Classification or regression: Given training data, $\{(X_i, y_i), i = 1, 2, \dots\}$, learn to predict an attribute (y) based on others (X).
 - ▶ Classification: $y_i \in \{C_1, \dots, C_M\}$; Regression: $y_i \in \Re$.

Supervised learning



Supervised learning



Machine learning encompasses many different data analysis scenarios.

- Predictive or Supervised Learning:
 - ▶ Classification or regression: Given training data, $\{(X_i, y_i), i = 1, 2, \dots\}$, learn to predict an attribute (y) based on others (X).
 - ▶ Classification: $y_i \in \{C_1, \dots, C_M\}$; Regression: $y_i \in \Re$.
 - Supervised in the sense we know the 'correct answer' (modulo noise) for training data.
 - Variations: multi-label classification, semi-supervised learning, ordinal regression, learning under label noise etc.
- ➤ This is the most common form of ML application. ("Current AI is better called Prediction Machines")
- ▶ In this course we mainly consider supervised learning.

Reinforcement Learning

- ► Reinforcement Learning: 'Learning by doing'. For example, how we learn to ride a bicycle.
- The feedback we get during training is only 'evaluative' (and noisy).
- ► Training data essentially consists of sample trajectories.
- Useful in many decision making and control applications.
 (AlphaGO is a reinforcement learning system)

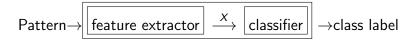
Unsupervised Learning

- Unsupervised Learning: Analysis of 'unlabelled' data.
 - Clustering
 - Frequent Patterns (Market basket analysis)
 - Dimensionality reduction, latent factor analysis.
 - Topic Discovery
 - Collaborative filtering (Imputing missing values)

Pattern Recognition

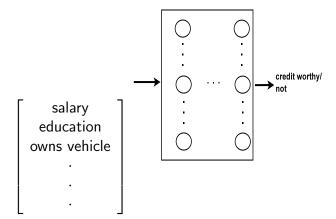
- ► Pattern Recognition is an older name (for supervised learning)
- A basic attribute of people categorisation of sensory input
- Examples of (human) Pattern Recognition tasks
 - 'Reading' facial expressions
 - Recognising Speech
 - Reading a Document
 - Identifying a person by fingerprints
 - Diagnosis from medical images
 - Wine tasting

Machine Recognition of Patterns

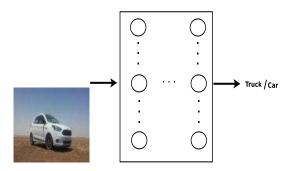


► The input can be 'anything' and output is one of finitely many classes.

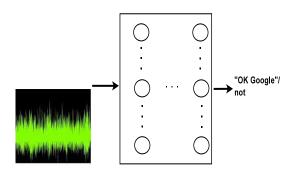
Input pattern can be a vector of measurements



Input Pattern can be an image



Input Pattern can be a 1D time signal

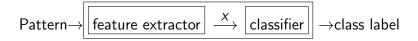


Machine Recognition of Patterns



- ▶ Input pattern can be a vector of measurements, an image, a 1D time signal, a multi-variate time series, a video · · ·
- ► Feature extractor makes some measurements on the input pattern.
- ▶ X is called *Feature Vector*. Often, $X \in \Re^n$.
- Classifier maps each feature vector to a class label.
- Features to be used are problem-specific.

Machine Recognition of Patterns



- Feature Extraction and classification may be fused together (For example, Neural Network models)
- ▶ We can think of pattern recognition system as mapping input pattern (can be viewed as a vector, X) to class label.

Many Examples

- Speech recognition
- Document Classification (e.g., spam detection, sentiment analysis)
- Biometrics-based authentication,
- Video Surveillance,
- Credit Screening,
- **•** • •

A Simple Pattern Recognition Problem

- Problem: 'Spot the Right Candidate'
- Features:
 - ▶ x₁: Marks based on academic record
 - x₂: Marks in the interview
- A Classifier: $ax_1 + bx_2 > c \Rightarrow$ 'Good' Another Classifier: $x_1x_2 > c \Rightarrow$ 'Good' (or $(x_1 + a)(x_2 + b) > c$).
- Design of classifier:
 We have to choose a specific form for the classifier.
 What values to use for parameters such as a, b, c?

Another simple PR problem

- Problem: "Sentiment Analysis"
- Pattern: A text document

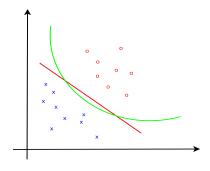
"every now and then a movie comes along from a suspect studio with every indication that it will be a stinker and to everybody's surprise perhaps even of the studio the film becomes a critical darling ..."

- We want to classify it as, say, positive or negative (without full semantic understanding!)
- ► Features??
 We can use, e.g., "bag of words" representation
 (Feature vector can be very high dimensional)
- Structure for Classifier ??

Designing Classifiers

- Need to decide how feature vector values determine the class.
 - (How different marks reflect goodness of candidate) (How different words indicate positive sentiment)
- In most applications, not possible to design classifier from 'physics of the problem'.
- ► Often the only information available for the design is: A training set of example patterns.
- ▶ Training set: $\{(X_i, y_i), i = 1, ..., \ell\}$. Here X_i is an example feature vector of class y_i .

Training set: Spot-Right-Candidate



Regression Problems

- ► Closely related problem. Output is continuous-valued rather than discrete as in classifiers.
- ▶ Here training set of examples could be $\{(X_i, y_i), i = 1, ..., \ell\}, X_i \in \mathcal{X}, y_i \in \Re.$
- ► The prediction variable, *y*, is continuous; rather than taking finitely many values.
- Similar learning techniques needed to infer the underlying functional relationship between X and y. (Regression function of y on X).

Examples of regression problems

- ▶ Time series prediction: Given a series x_1, x_2, \cdots , find a function to predict x_n .
- ▶ Based on past values: Find a 'best' function $\hat{x}_n = h(x_{n-1}, x_{n-2}, \dots, x_{n-p})$
 - Predict stock prices, exchange rates etc.
 - Linear prediction model used in speech analysis
 - Equalisers in communication systems
- More general predictors can use other variables also.
 - Predict rainfall based on measurements and (possibly) previous years' data.

Example of Regression: Equaliser

$$\exists x \to x(k) \to \exists channel \to Z(k) \to \exists filter \to y(k) \to \exists Rx$$

- We want y(k) = x(k).
- Design (or adapt) the filter to achieve this. We can choose a filter as

$$y(k) = \sum_{i=0}^{T} a_i Z(k-i)$$

Find 'best' a_i – a function learning problem.

▶ Training set: $\{(x(k), Z(k)), k = 1, 2, \dots, N\}$

- ▶ Both classification and regression involve learning from examples.
- ► As we said they represent the basic problem addressed under Machine learning.

Learning from Examples – Generalization

- ► To obtain a classifier (or a regression function) we use the training set.
- We 'know' the class label of patterns (or the values for prediction variable) in the training set.
- ► Errors on the training set do not necessarily tell how good is the classifier.
- Any classifier that amounts to only storing the training set is useless.
- Interested in the 'generalization abilities' how does our classifier perform on unseen or new patterns.

- ▶ In practice we assess the generalization ability of a a learnt classifier using the so called *t*est set.
- ▶ Basic tenet of ML: Training data is 'similar' to the data on which the classifier is expected to perform well.

Designing Classifiers

- The classifier should perform well inspite of inherent variability of patterns and noise in feature extraction and/or in class labels as given in training set.
- The difficulties are
 - Lot of variability in patterns of a single class
 - ► Feature vectors of patterns from different classes can be arbitrarily close.
 - Noise in measurements

Variability in Patterns



stadter's Metamagical Themes: Questing for the Essence of Mind and Pattern [HOF1985]).

► Statistical Pattern Recognition – An approach where the variabilities are captured through probabilistic models.

The Statistical Approach

- We assume that the training examples are drawn *iid* according to some joint distribution of (X, y).
- ► The learnt classifier is evaluated using random examples drawn from the same distribution.
- ► Given a distribution from which data comes, we can ask what is the 'best' classifier.
- ▶ We can use the training data to learn the relevant distributions and then implement the 'best' classifier.

Notation

- $ightharpoonup \mathcal{X}$ the feature space. (We take $\mathcal{X}=\Re^n$).
- $\mathcal{Y} = \{1, \dots, K\}$ the set of class labels.
- ▶ The simplest case is K = 2. (Many times, we consider a 2-class problem to simplify notation).
- ▶ We can, in principle, solve a general problem if we can tackle the K=2 case. (E.g., 'one-Vs-rest')

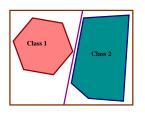
Notation – Classifiers

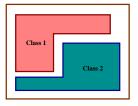
- ▶ A classifier: $h: \mathcal{X} \to \mathcal{Y}$
- ▶ Sometimes we take $h: \mathcal{X} \to \mathcal{A} \subset \Re^K$ as a classifier. (Here K is the number of classes).
- ▶ The j^{th} component of $h(\cdot)$ could be 'score' for class-j.
- ▶ We will write *h* for any classifier.

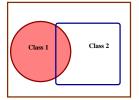
Notation – Class conditional densities

- ▶ f_i the probability density function of the feature vectors from class-i, i = 0, 1.
- f_i are called class conditional densities.
- ▶ Let $\mathbf{X} = (X_1, \dots, X_n) \in \Re^n$ represent the feature vector.
- ▶ Then f_i is the (conditional) joint density of the random variables X_1, \dots, X_n given that **X** is from class-i.

- Class conditional densities model the variability in the feature values.
- ► For example, the two classes can be uniformly distributed in the two regions as shown.







Notation – prior and posterior probabilities

- $p_i = \text{Prob}[y = i]$ prior probabilities
- By Bayes theorem

$$q_i(\mathbf{x}) = \frac{f_i(\mathbf{x})p_i}{Z}$$

where $Z = \sum_i f_i(\mathbf{x}) p_i$.

- ▶ We would not have knowledge of f_i , p_i etc.
- ▶ All we have is the training set of examples.
- ▶ We have to use the training data to learn a 'model'

- ► The statistical viewpoint gives us one way of looking for 'optimal' classifier.
- ► We can say, for example, we want a classifier that has least probability of misclassifying a random pattern (drawn from the underlying distributions).

Bayes Classifier (2-class case)

The Bayes classifier:

$$h_B(\mathbf{x}) = 0 \text{ if } q_0(\mathbf{x}) > q_1(\mathbf{x})$$

= 1 otherwise

- Given the underlying probability model, this is the optimal classifier for minimizing probability of error. (We show this later).
- ▶ $q_0(\mathbf{x}) > q_1(\mathbf{x})$ is same as $p_0 f_0(\mathbf{x}) > p_1 f_1(\mathbf{x})$. We need to learn p_0, p_1, f_0, f_1 from the data to implement Bayes Classifier.
- ► This is an example of what is called a Generative Model based approach.

Generative Models

- ▶ Training data: $\{(\mathbf{X}_i, y_i), i = 1, ..., \ell\}$
- We view them as *iid* realizations of (X, y).
- ▶ Generative model: Joint distribution of (\mathbf{X}, y) .
- ▶ For example, learning f_i and p_i .
- ▶ Bayes classifier is a generative model based approach
- ▶ There are different ways to represent generative models.

Learning a Generative Model

- ▶ Given *iid* data, $\mathcal{D} = \langle \mathbf{z_1}, \cdots, \mathbf{z_n} \rangle$ we want to estimate the underlying probability distribution.
- ▶ One can assume a parametric model: $f(\mathbf{z}|\theta)$.
- ▶ That is, we assume form of distribution is known and we need to estimate the parameters, θ .
- ightharpoonup Parameters θ are learnt using training data.
- ► The density (with learnt parameter values) is used to derive the optimal classifier.
- ► There are different techniques to fit a density model to given data.

Discriminative models

- We model only the conditional distribution of y conditioned on X.
- ▶ That is, we (directly) learn $q_i(\mathbf{X})$.
- We need some representation for the posterior probabilities.
- Or some other parameterized representation for the classifier.

How to Rate Different Classifiers

We can rate different classifiers, for example, by

$$F(h) = \text{Prob}[h(\mathbf{X}) \neq y(\mathbf{X})]$$

where $y(\mathbf{X})$ denotes the (random variable that is the) class of \mathbf{X} .

- \triangleright F(h) is probability that h misclassifies a random X.
- Optimal classifier one with lowest value of F.
- Bayes Classifier minimizes this F.
- Note that for a given h we cannot even calculate F(h) unless we know the joint distribution of (X, y).

Risk of a Classifier

- ▶ A more general way to assign figure of merit is to use a loss function, $L: \mathcal{A} \times \mathcal{Y} \rightarrow \Re^+$.
- ▶ The idea is that $L(h(\mathbf{X}), y(\mathbf{X}))$ denotes the loss suffered by h on a pattern X.
- Now we can define

$$F(h) = E[L(h(\mathbf{X}), y(\mathbf{X}))]$$

The F(h) is called **risk** of h.

Now the objective is to find a classifier with minimum risk.

Example: 0–1 Loss Function

► The 0-1 loss fn:

$$L(a,b) = 0$$
 if $a = b$
= 1 otherwise.

Now
$$F(h) = E[L(h(\mathbf{X}), y(\mathbf{X}))] = \text{Prob}[h(\mathbf{X}) \neq y(\mathbf{X})].$$
 (Same as before)

- A more general loss function, in the 2-class case, is to have $L(0,1) \neq L(1,0)$. (L(0,0) = L(1,1) = 0).
- Now F(h) is the expected cost of misclassification.
- ▶ The relative values of L(0,1) and L(1,0) determine how we trade errors.

Learning Classifiers

Recall we want h to minimize

$$F(h) = E[L(h(\mathbf{X}), y(\mathbf{X}))]$$

- We can (in principle) achieve this if we know joint distribution of (X, y).
- Example: Bayes classifier
- Hence one approach is to learn the joint distribution from data.
- Once we learn the joint distribution, it can be used for other purposes also.

Learning Classifiers

▶ We want a *h* to minimize

$$F(h) = E[L(h(\mathbf{X}), y(\mathbf{X}))]$$

- ▶ We can choose a parametric form: $h(W, \cdot)$.
- ► For example, for a K-class problem

$$h(W, \mathbf{x}) = j \text{ iff } g_j(W, \mathbf{x}) > g_i(W, \mathbf{x}), \ \forall i \neq j$$

- ▶ We can think of $g_i(W, \mathbf{x})$ to be approximation of $q_i(\mathbf{x})$.
- ▶ The g_i are called discriminant functions
- We can learn W to minimize risk.
- A discriminative approach.

Linear Classifiers

- ▶ Consider 2-class case with $h(W, \mathbf{x}) = \text{sign}(g(W, \mathbf{x}))$.
- ► Choose: $g(W, \mathbf{x}) = W^T \mathbf{x} + b$
- Perceptron is one of the earliest such Linear Classifiers.
- ▶ $h(W, \mathbf{x}) = \text{sign}(g(W, \mathbf{x}))$ is often called a discriminant function based Classifier.
- $g(W, \mathbf{x}) = W^T \mathbf{x} + b$ is called a linear discriminant function.

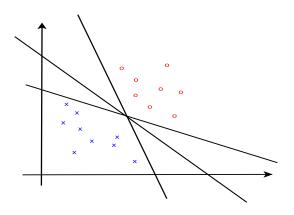
Linear Separability

▶ The training set: $\{(\mathbf{X}_i, y_i), i = 1, \dots, \ell\}$. of patterns is said to be **linearly separable** if there exists W^*, b^* such that

$$\mathbf{X}_{i}^{T}W^{*} + b^{*} > 0 \text{ if } y_{i} = 1$$
 $< 0 \text{ if } y_{i} = 0$

- Any W^* , b^* that satisfies the above is called a separating hyperplane. (The separating hyperplane is given by $\mathbf{X}^T W^* + b^* = 0$).
- ► There exist infinitely many separating hyperplanes if the set is linearly separable.

Linearly Separable Data – infinitely many separating hyperplanes



Learning Classifiers

- ► Consider $h(W, \mathbf{X}) = \text{sign}(g(W, \mathbf{X}))$.
- ▶ Now each classifier is defined by a parameter vector, *W*.
- So, we need to find W to minimize

$$F(W) = E[L(h(W, \mathbf{X}), y(\mathbf{X}))]$$

- ► Since we do not know the relevant joint distribution, this is not a straight-forward optimization problem.
- We can approximate the Expectation above by sample mean.

Empirical Risk

▶ Consider the function \hat{F} defined by

$$\hat{F}(W) = \frac{1}{\ell} \sum_{i=1}^{\ell} L(h(W, \mathbf{X}_i), y_i)$$

where $\{(\mathbf{X}_i, y_i), i = 1, \dots, \ell\}$ is the training set of examples.

- ► Then F̂(W), called empirical risk, is a good approximation to F(W). (Law of large numbers; assume examples are iid)
- ▶ So, we can minimize \hat{F} instead.

Empirical Risk Minimization

Empirical risk is the 'training error'

$$\hat{F}(W) = \frac{1}{\ell} \sum_{i=1}^{\ell} L(h(W, X_i), y_i)$$

- We search over a family of classifiers to minimize empirical risk.
- The true risk is the 'test error'

$$F(W) = E[L(h(W, X), y(X))]$$

- ▶ We actualy want the minimizer of the true risk.
- If we have 'sufficient' number of 'representative' training samples then minimizer of \hat{F} would be good enough.
- ► Empirical Risk Minimization is a standard ML strategy.

Learning Linear Classifiers

- ▶ Linear classifier (2-class): $h(W, \mathbf{X}) = \text{sign}(W^T \mathbf{X})$.
- ▶ We need to find *W* to minimize

$$\hat{F}(W) = \frac{1}{\ell} \sum_{i=1}^{\ell} L(h(W, \mathbf{X}_i), y_i)$$

- ▶ In general we need some optimization techniques.
- As defined, h (and hence \hat{F}) may be discontinuous. Also, if we use 0–1 loss function, L is also discontinuous.
- ▶ We can, e.g., take $h(W, \mathbf{X}) = W^T \mathbf{X}$ and use losses other than 0–1 loss.

Example – Learning a Linear Classifier

- ▶ squared error loss: $L(h(W, X), y) = (h(W, X) y)^2$
- ▶ Suppose we use squared error loss with a linear classifier

$$\hat{F}(W) = \frac{1}{\ell} \sum_{i=1}^{\ell} (W^T \mathbf{X}_i - y_i)^2$$

.

- Now we can use standard optimization techniques to minimize \hat{F} .
- ▶ This is called the linear least squares method.

Linear Least squares method

- ▶ Consider a 2-class problem with $y \in \{0, 1\}$.
- Suppose we want to minimize (over all possible g)

$$F = E[g(\mathbf{X}) - y]^2$$

- ▶ Solution: $g^*(X) = E[y|X] = P[y = 1|X] = q_1(X)$
- ► Thus, in linear least squares method, we are trying to find 'best linear approximation' of the posterior probability

Logistic Regression

- Linear function is not a good model for posterior probability.
- ▶ We can instead choose a model

$$P[y=1|\mathbf{X}] = \frac{1}{1 + \exp(-W^T\mathbf{X})}$$

► This is known as Logistic Regression

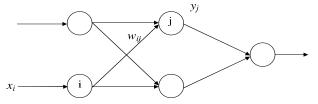
- ► There are efficient algorithms for learning linear classifiers.
- ▶ In learning such linear models we can use $W^T \Phi(X)$ instead of $W^T X$ where $\Phi(X) = [\phi_1(X), \cdots, \phi_m(X)]^T$ as long as ϕ_i are fixed functions.
- ▶ It is like using $z_i = \phi_i(X)$ as features.

Beyond Linear Models

- Learning linear models (classifiers) is generally efficient.
- ▶ However, linear models are not always sufficient.
- Best linear functions may still be a poor fit.
- How to tackle general situations?
- ► Here are some possible viewpoints.

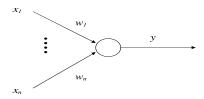
The Neural Networks Approach

- ► Find a 'good' parameterized class of nonlinear discriminant functions
- Multilayer feedforward neural nets are one such class



- Nonlinear functions are built up through composition of summation and sigmoids.
- Useful for both classification and Regression.
- Models are inspired by the architecture of brain

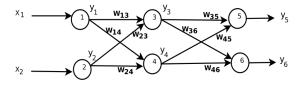
Single Neuron Models



- \triangleright x_i are inputs into the (artificial) neuron and w_i are the corresponding weights. y is the output of the neuron
- Net input : $\eta = \sum_j w_j x_j$
- output: $y = f(\eta)$, where f(.) is called activation function (Perceptron, AdaLinE are such models).

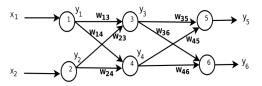
Network of Neurons

We can connect a number of such units or neurons to form a network. Inputs to a neuron can be outputs of other neurons (and/or external inputs).



► Notation:

 y_j — output of j^{th} neuron; w_{ij} — weight of connection from neuron i to neuron j.



- ► Each neuron computes weighted sum of inputs and passes it through its activation function, to compute output
- ▶ For example, output of neuron 5 is

$$y_5 = f_5(w_{35} y_3 + w_{45} y_4)$$

= $f_5(w_{35} f_3(w_{13}y_1 + w_{23}y_2) + w_{45} f_4(w_{14}y_1 + w_{24}y_2))$

- ▶ By convention, we take $y_1 = x_1$ and $y_2 = x_2$.
- ▶ Here, x_1, x_2 are inputs and y_5, y_6 are outputs.

- ▶ A single neuron 'represents' a class of functions from \Re^m to \Re .
- Specific set of weights realizes specific functions.
- ▶ By interconnecting many units/neurons, networks can represent more complicated functions from \Re^m to $\Re^{m'}$.
- ► The architecture constrains the function class that can be represented. Weights define specific function in the class.

Feedforward networks

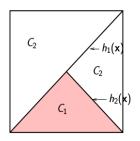
- ► These networks are very effective in learning nonlinear pattern classifiers.
- ► They learn under supervised learning framework given examples of needed input-output behaviour, the weights are adapted to achieve that function.
- ► Trained through minimizing empirical risk (training error) using, e.g., squared error loss.
- Gradient descent on this empirical risk is the so called backpropagation algorithm.

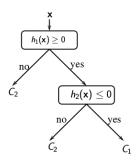
The Decision Tree Approach

- ▶ Divide feature space so that a linear classifier is enough in each region
- Gives us a piece-wise linear classifier.
- Decision trees represent such classifiers.

Decision Trees - Overview

- ► A decision tree is a very popular piece-wise linear classification method.
- ▶ Here is an example decision tree





► Such tree-based models are possible for regression also.

Decision Trees - Overview

- ► Each (non-leaf) node is labelled with a so called 'split rule'.
- All leaf nodes are labelled with a class label.
- Given a feature vector, at each node we go to one of the children based on the value of split rule on this feature vector.
- ▶ When we reach a leaf that gives the classification of the feature vector.
- Most decision tree algorithms learn the tree in a top-down fashion under a greedy heuristic.

Support Vector Machines idea

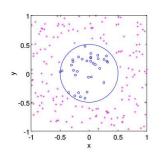
- ► Map X nonlinearly into a high dimensional space and try a linear classifier there.
- ▶ Let $X = [x_1 \ x_2]$ and let $\phi : \Re^2 \to \Re^6$ given by $Z = [z_0 \ z_1 \cdots z_5] = \phi(X) = [1 \ x_1 \ x_2 \ x_1^2 \ x_2^2 \ x_1x_2]$
- Now,

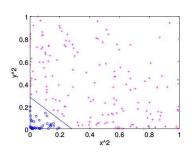
 $g(X)=a_0+a_1x_1+a_2x_2+a_3x_1^2+a_4x_2^2+a_5x_1x_2$ is a quadratic discriminant function in \Re^2 ; but

$$g(Z) = a_0z_0 + a_1z_1 + a_2z_2 + a_3z_3 + a_4z_4 + a_5z_5$$

is a linear discriminant function in the ' $\phi(X)$ ' space.

Transforming Patterns to become Linearly Separable





- ► The SVM method does this mapping implicitly using the so called kernel function.
- ▶ It results in a quadratic programming problem (optimizing a quadratic objective function under linear constraints). Computationally efficient.

Many Other issues

- Model Selection: How to choose and validate a parametric model.
- Model Estimation: What we considered methods to learn the classifier
- Model Assessment: How to estimate true risk of learnt classifier (training, validation and testing)
- Scalability of algorithms
- Noise Robustness
- Dimensionality Reduction/Models with Latent variables.
- Classifier Combinations:

Organization of this course

- Bayes classifier for minimizing risk (and some variations)
- Estimation of class conditional densities.
- ▶ Parametric and non-parametric models
- ML and Bayesian estimation
- Mixture models and EM algorithm
- Probabilistic graphical models (?)

- ▶ Learning linear classifiers and regression models
- Perceptron and LMS algorithm
- ▶ Linear Least squares estimation.
- Logistic regression.

- ► Simple introduction to statistical learning theory
- Probably Approximately Correct (PAC) learning framework
- ► Complexity of a learning problem VC dimension
- Consistency of Empirical Risk minimization

- Learning Nonlinear models Neural networks.
- Feedforward networks and Backpropagation
- ▶ RBF Networks (?)
- Some issues in deep neural networks
- CNNs, Autoencoders
- Recurrent neural networks (?)
- ▶ RBMs, other generative models such as GAN, variational autoencoders (?)

- ► Learning nonlinear models SVMs
- Optimal Separating hyperplane
- SVM (Kernel based) methods for classification and regression

- Assessing learnt classifier, cross validation, Bagging and Boosting
- Classifier combinations, AdaBoost
- ▶ PCA, Feature Extraction/dimensionality reduction

Conclusions

- ML comprises of methods to fit models to data (for prediction/decision making)
- Statistical approach to ML uses probability models
- Generative models learn joint distribution of (X, y).
- Discriminative models learn conditional distribution of y given X.
- Empirical risk minimization is a general strategy for learning.

Thank You!